

## Single 16 and 8/Differential 8-Channel and 4-Channel CMOS Analog Multiplexers

The HI-506/HI-507 and HI-508/HI-509 monolithic CMOS multiplexers each include an array of sixteen and eight analog switches respectively, a digital decoder circuit for channel selection, voltage reference for logic thresholds, and an enable input for device selection when several multiplexers are present. The Dielectric Isolation (DI) process used in fabrication of these devices eliminates the problem of latchup. DI also offers much lower substrate leakage and parasitic capacitance than conventional junction isolated CMOS (see Application Notes AN520 and AN521).

The switching threshold for each digital input is established by an internal +5V reference, providing a guaranteed minimum 2.4V for logic "1" and maximum 0.8V for logic "0". This allows direct interface without pullup resistors to signals from most logic families: CMOS, TTL, DTL and some PMOS. For protection against transient overvoltage, the digital inputs include a series 200Ω resistor and diode clamp to each supply.

The HI-506 is a single 16-Channel, the HI-507 is an 8-Channel differential, the HI-508 is a single 8-Channel and the HI-509 is a 4-Channel differential multiplexer.

If input overvoltages are present, the HI-546/HI-547/HI-548/HI-549 multiplexers are recommended.

## Features

- Low ON Resistance . . . . . 180Ω
- Wide Analog Signal Range . . . . . ±15V
- TTL/CMOS Compatible
- Access Time . . . . . 250ns
- Maximum Power Supply . . . . . 44V
- Break-Before-Make Switching
- No Latch-Up
- Replaces DG506A/DG506AA and DG507A/DG507AA
- Replaces DG508A/DG508AA and DG509A/DG509AA

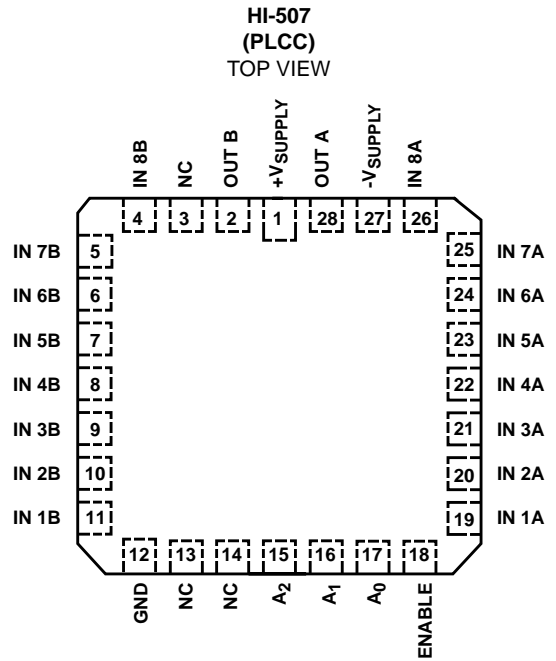
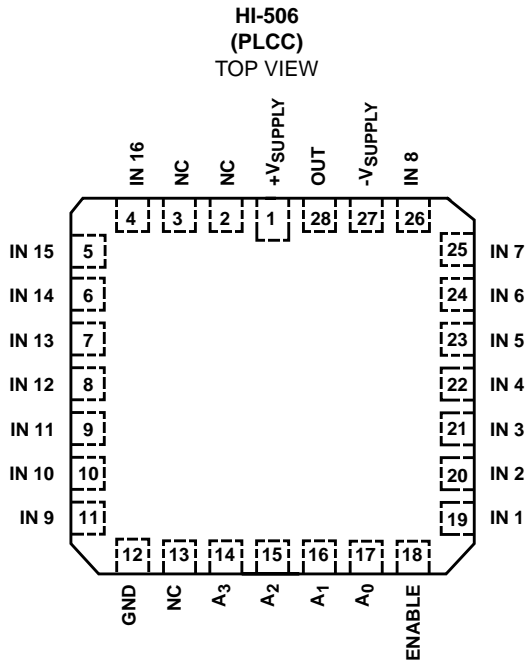
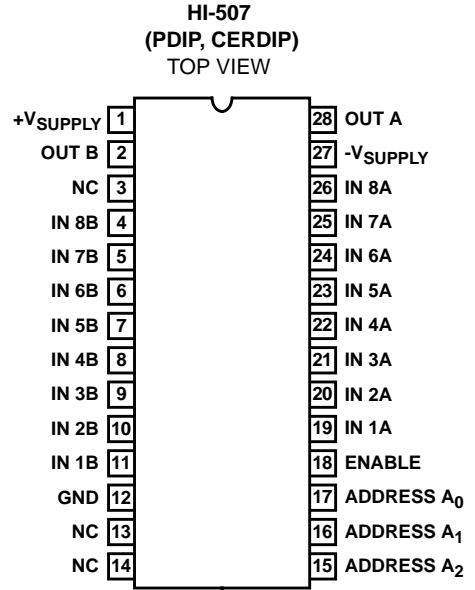
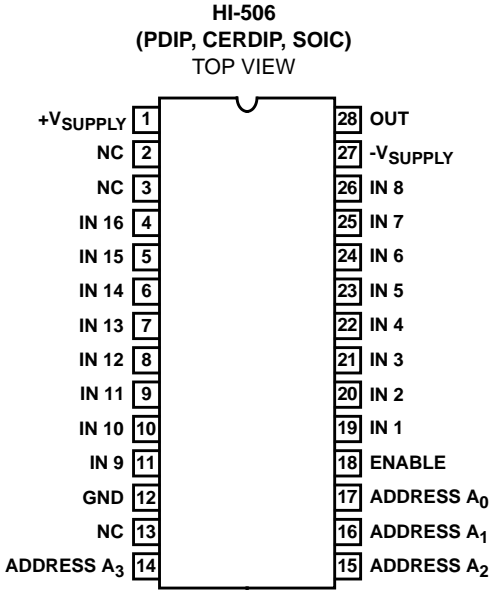
## Applications

- Data Acquisition Systems
- Precision Instrumentation
- Demultiplexing
- Selector Switch

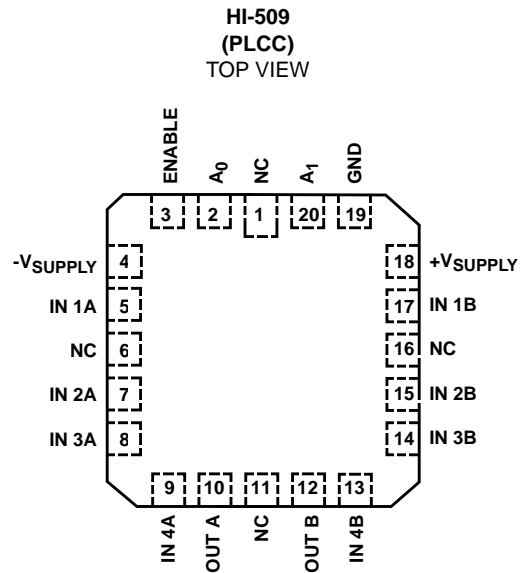
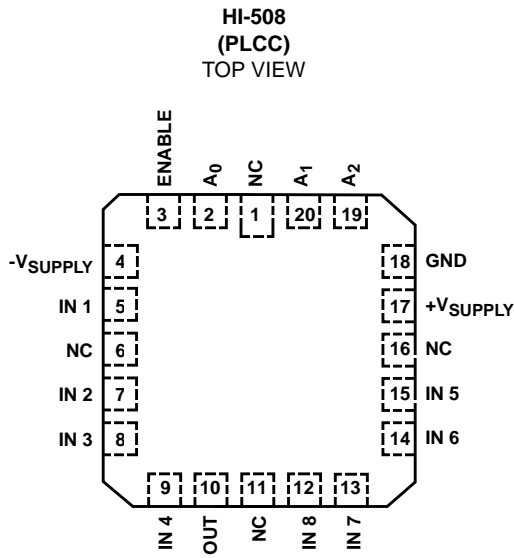
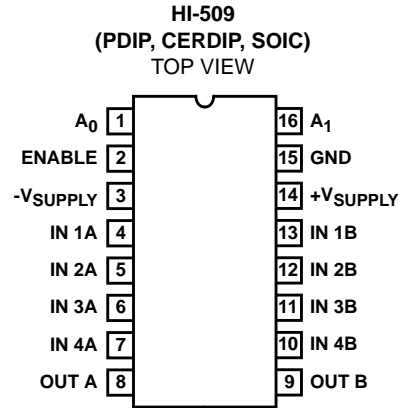
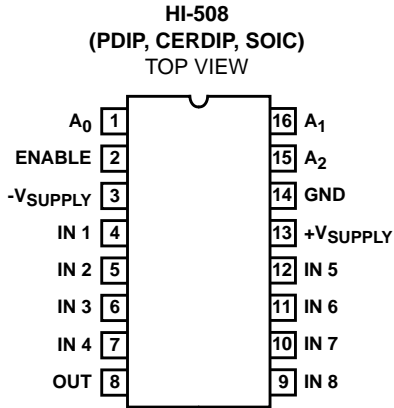
## Ordering Information

| PART NUMBER | TEMP. RANGE (°C) | PACKAGE      | PKG. NO. |
|-------------|------------------|--------------|----------|
| HI9P0506-9  | -40 to 85        | 28 Ld SOIC   | M28.3    |
| HI3-0506-5  | 0 to 75          | 28 Ld PDIP   | E28.6    |
| HI4P0506-5  | 0 to 75          | 28 Ld PLCC   | N28.45   |
| HI1-0506-5  | 0 to 75          | 28 Ld CERDIP | F28.6    |
| HI1-0506-4  | -25 to 85        | 28 Ld CERDIP | F28.6    |
| HI1-0506-2  | -55 to 125       | 28 Ld CERDIP | F28.6    |
| HI4P0507-5  | 0 to 75          | 28 Ld PLCC   | N28.45   |
| HI3-0507-5  | 0 to 75          | 28 Ld PDIP   | E28.6    |
| HI1-0507-2  | -55 to 125       | 28 Ld CERDIP | F28.6    |
| HI1-0508-5  | 0 to 75          | 16 Ld CERDIP | F16.3    |
| HI3-0508-5  | 0 to 75          | 16 Ld PDIP   | E16.3    |
| HI1-0508-4  | -25 to 85        | 16 Ld CERDIP | F16.3    |
| HI1-0508-2  | -55 to 125       | 16 Ld CERDIP | F16.3    |
| HI4P0508-5  | 0 to 75          | 20 Ld PLCC   | N20.35   |
| HI9P0508-9  | -40 to 85        | 16 Ld SOIC   | M16.15   |
| HI9P0508-5  | 0 to 75          | 16 Ld SOIC   | M16.15   |
| HI9P0509-5  | 0 to 75          | 16 Ld SOIC   | M16.15   |
| HI1-0509-4  | -25 to 85        | 16 Ld CERDIP | F16.3    |
| HI1-0509-5  | 0 to 75          | 16 Ld CERDIP | F16.3    |
| HI3-0509-5  | 0 to 75          | 16 Ld PDIP   | E16.3    |
| HI4P0509-5  | 0 to 75          | 20 Ld PLCC   | N20.35   |
| HI1-0509-2  | -55 to 125       | 16 Ld CERDIP | F16.3    |

Pinouts



Pinouts (Continued)



Truth Tables

HI-506

| A <sub>3</sub> | A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | X              | L  | None         |
| L              | L              | L              | L              | H  | 1            |
| L              | L              | L              | H              | H  | 2            |
| L              | L              | H              | L              | H  | 3            |
| L              | L              | H              | H              | H  | 4            |
| L              | H              | L              | L              | H  | 5            |
| L              | H              | L              | H              | H  | 6            |
| L              | H              | H              | L              | H  | 7            |
| L              | H              | H              | H              | H  | 8            |
| H              | L              | L              | L              | H  | 9            |
| H              | L              | L              | H              | H  | 10           |
| H              | L              | H              | L              | H  | 11           |
| H              | L              | H              | H              | H  | 12           |
| H              | H              | L              | L              | H  | 13           |
| H              | H              | L              | H              | H  | 14           |
| H              | H              | H              | L              | H  | 15           |
| H              | H              | H              | H              | H  | 16           |

HI-508

| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | L  | None         |
| L              | L              | L              | H  | 1            |
| L              | L              | H              | H  | 2            |
| L              | H              | L              | H  | 3            |
| L              | H              | H              | H  | 4            |
| H              | L              | L              | H  | 5            |
| H              | L              | H              | H  | 6            |
| H              | H              | L              | H  | 7            |
| H              | H              | H              | H  | 8            |

HI-509

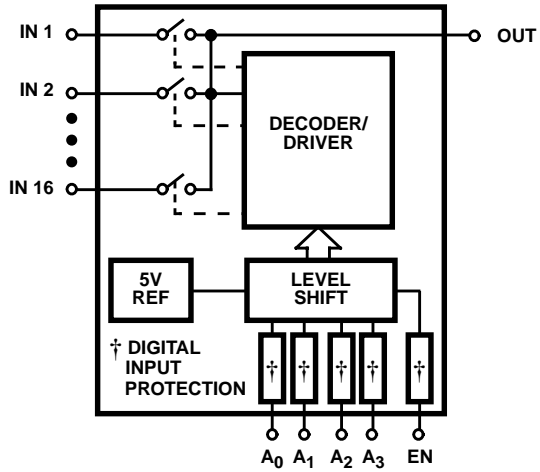
| A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL PAIR |
|----------------|----------------|----|-------------------|
| X              | X              | L  | None              |
| L              | L              | H  | 1                 |
| L              | H              | H  | 2                 |
| H              | L              | H  | 3                 |
| H              | H              | H  | 4                 |

HI-507

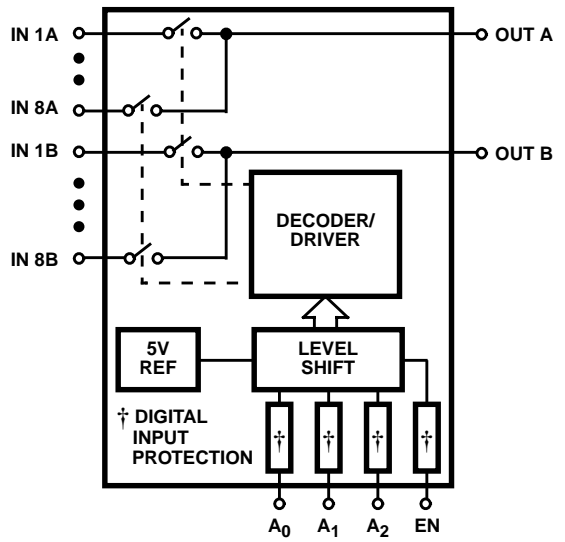
| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | L  | None         |
| L              | L              | L              | H  | 1            |
| L              | L              | H              | H  | 2            |
| L              | H              | L              | H  | 3            |
| L              | H              | H              | H  | 4            |
| H              | L              | L              | H  | 5            |
| H              | L              | H              | H  | 6            |
| H              | H              | L              | H  | 7            |
| H              | H              | H              | H  | 8            |

Functional Diagrams

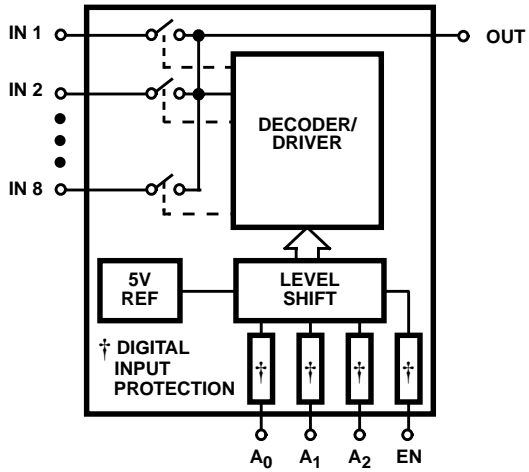
HI-506



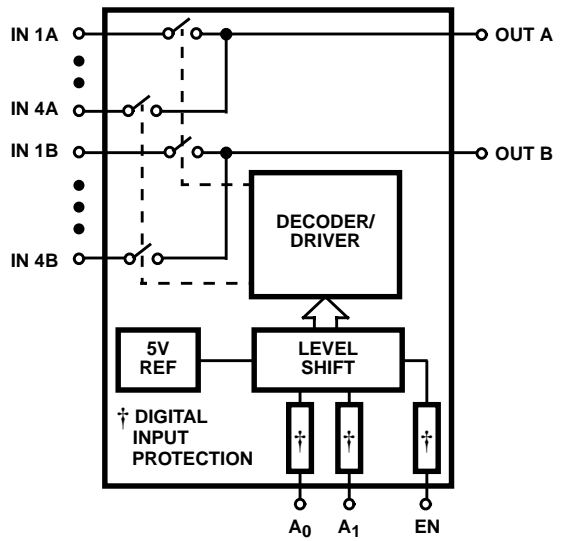
HI-507



HI-508

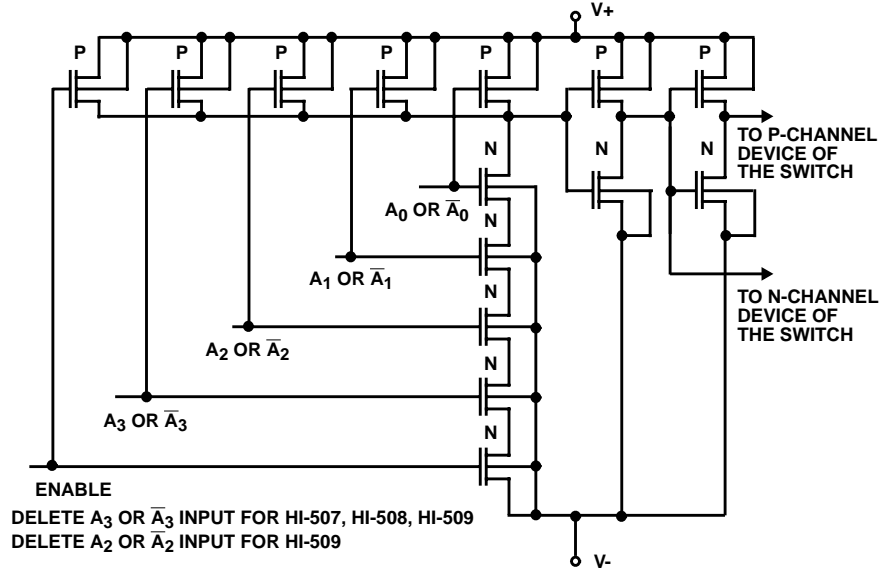


HI-509

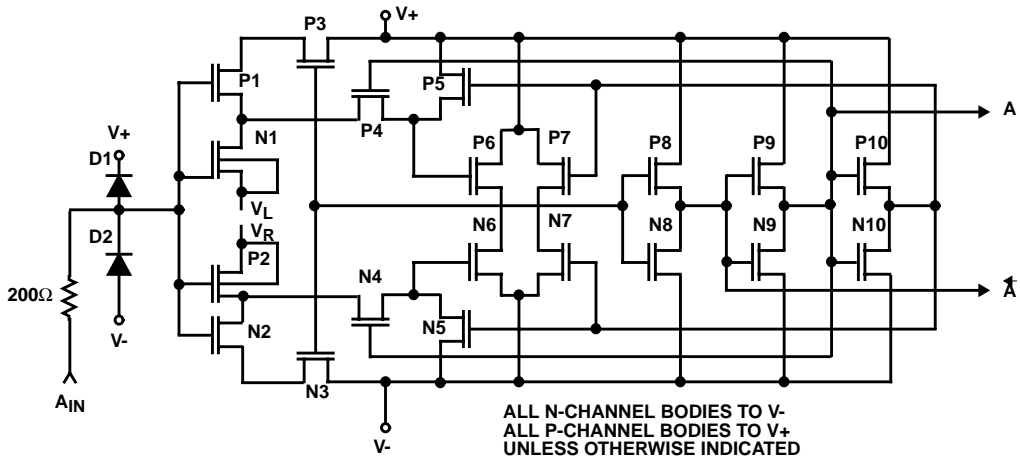


Schematic Diagrams

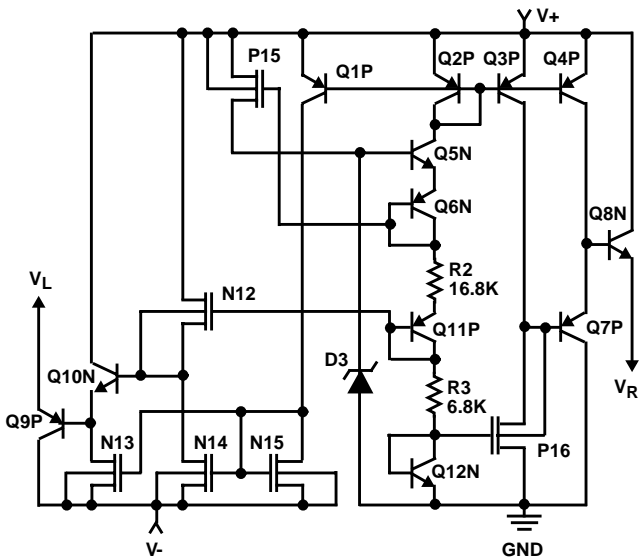
ADDRESS DECODER



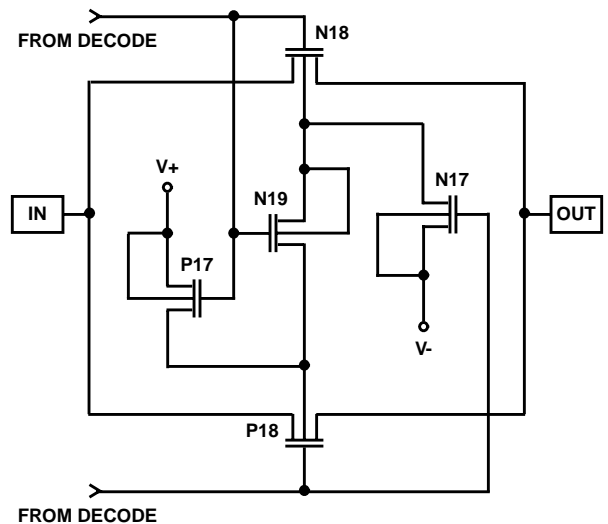
ADDRESS INPUT BUFFER LEVEL SHIFTER



TTL REFERENCE CIRCUIT



MULTIPLEX SWITCH



# HI-506, HI-507, HI-508, HI-509

## Absolute Maximum Ratings

|   |   |
|---|---|
| V+ to V-  | +44V  |
| V+ to GND   | +22V  |
| V- to GND   | -25V  |
| Digital Input Voltage (V <sub>EN</sub> , V <sub>A</sub> )   | (V-) -4V to (V+) +4V or 20mA,<br>Whichever Occurs First |
| Analog Signal (V <sub>IN</sub> , V <sub>OUT</sub> , Note 2) | (V-) -2V to (V+) +2V                                    |
| Continuous Current, In or Out                               | 20mA  |
| Peak Current, In or Out (Pulsed 1ms, 10% Duty Cycle Max)    | 40mA  |

## Operating Conditions

|                      |                |
|----------------------|----------------|
| Temperature Ranges   |                |
| HI-506/507/508/509-2 | -55°C to 125°C |
| HI-506/508/509-4     | -25°C to 85°C  |
| HI-506/507/508/509-5 | 0°C to 75°C    |
| HI-506/508-9         | -40°C to 85°C  |

## Thermal Information

|  |   |                      |
|--|---|----------------------|
| Thermal Resistance (Typical, Note 1)     | $\theta_{JA}$ (°C/W)                      | $\theta_{JC}$ (°C/W) |
| 16 Ld CERDIP Package                     | 85  | 32                   |
| 16 Ld SOIC Package                       | 115                                       | N/A                  |
| 16 Ld PDIP Package                       | 100                                       | N/A                  |
| 20 Ld PLCC Package                       | 80  | N/A                  |
| 28 Ld CERDIP Package                     | 55  | 18                   |
| 28 Ld PDIP Package                       | 60  | N/A                  |
| 28 Ld SOIC Package                       | 70  | N/A                  |
| 28 Ld PLCC Package                       | 70  | N/A                  |
| Maximum Junction Temperature             |   |                      |
| Ceramic Packages                         | 175°C                                     |                      |
| Plastic Packages                         | 150°C                                     |                      |
| Maximum Storage Temperature Range        | -65°C to 150°C                            |                      |
| Maximum Lead Temperature (Soldering 10s) | 300°C<br>(SOIC and PLCC - Lead Tips Only) |                      |

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTES:

- $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.
- Signals on IN or OUT exceeding V+ or V- are clamped by internal diodes. Limit resulting current to maximum current ratings. If an overvoltage condition is anticipated (analog input exceeds either power supply voltage), the Harris HI-546/HI-547/HI-548/HI-549 multiplexers are recommended.

**Electrical Specifications** Supplies = +15V, -15V; V<sub>AH</sub> (Logic Level High) = 2.4V; V<sub>AL</sub> (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section

| PARAMETER  | TEST CONDITIONS | TEMP (°C) | -2  |      |      | -4, -5, -9 |      |      | UNITS |
|--|-----------------|-----------|-----|------|------|------------|------|------|-------|
|  |                 |           | MIN | TYP  | MAX  | MIN        | TYP  | MAX  |       |
| <b>DYNAMIC CHARACTERISTICS</b>                       |                 |           |     |      |      |            |      |      |       |
| Access Time, t <sub>A</sub>                          |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Break-Before-Make Delay, t <sub>OPEN</sub>           |                 | 25        | 25  | 80   | -    | 25         | 80   | -    | ns    |
| Enable Delay (ON), t <sub>ON(EN)</sub>               |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Enable Delay (OFF), t <sub>OFF(EN)</sub>             |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Settling Time, t <sub>§</sub><br>(HI-506 and HI-507) | To 0.1%         | 25        | -   | 1.2  | -    | -          | 1.2  | -    | µs    |
|  | To 0.01%        | 25        | -   | 2.4  | -    | -          | 2.4  | -    | µs    |
| Settling Time, t <sub>§</sub><br>(HI-508 and HI-509) | To 0.1%         | 25        | -   | 360  | -    | -          | 360  | -    | ns    |
|  | To 0.01%        | 25        | -   | 600  | -    | -          | 600  | -    | ns    |
| Off Isolation  | Note 6          | 25        | 50  | 68   | -    | 50         | 68   | -    | dB    |
| Channel Input Capacitance, C <sub>S(OFF)</sub>       |                 | 25        | -   | 10   | -    | -          | 10   | -    | pF    |
| Channel Output Capacitance, C <sub>D(OFF)</sub>      | HI-506          | 25        | -   | 52   | -    | -          | 52   | -    | pF    |
|  | HI-507          | 25        | -   | 30   | -    | -          | 30   | -    | pF    |
|  | HI-508          | 25        | -   | 17   | -    | -          | 17   | -    | pF    |
|  | HI-509          | 25        | -   | 12   | -    | -          | 12   | -    | pF    |
| Digital Input Capacitance, C <sub>A</sub>            |                 | 25        | -   | 6    | -    | -          | 6    | -    | pF    |
| Input to Output Capacitance, C <sub>DS(OFF)</sub>    |                 | 25        | -   | 0.08 | -    | -          | 0.08 | -    | pF    |

## HI-506, HI-507, HI-508, HI-509

**Electrical Specifications** Supplies = +15V, -15V;  $V_{AH}$  (Logic Level High) = 2.4V;  $V_{AL}$  (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section **(Continued)**

| PARAMETER   | TEST CONDITIONS | TEMP (°C) | -2   |      |     | -4, -5, -9 |      |     | UNITS    |    |
|---|-----------------|-----------|------|------|-----|------------|------|-----|----------|----|
|   |                 |           | MIN  | TYP  | MAX | MIN        | TYP  | MAX |          |    |
| <b>DIGITAL INPUT CHARACTERISTICS</b>                                      |                 |           |      |      |     |            |      |     |          |    |
| Input Low Threshold, $V_{AL}$   |                 | Full      | -    | -    | 0.8 | -          | -    | 0.8 | V        |    |
| Input High Threshold, $V_{AH}$  |                 | Full      | 2.4  | -    | -   | 2.4        | -    | -   | V        |    |
| Input Leakage Current (High or Low), $I_A$                                | Note 5          | Full      | -    | -    | 1.0 | -          | -    | 1.0 | $\mu$ A  |    |
| <b>ANALOG CHANNEL CHARACTERISTICS</b>                                     |                 |           |      |      |     |            |      |     |          |    |
| Analog Signal Range, $V_{IN}$   |                 | Full      | -15  | -    | +15 | -15        | -    | +15 | V        |    |
| On Resistance, $r_{ON}$   | Note 3          | 25        | -    | 180  | 300 | -          | 180  | 400 | $\Omega$ |    |
| $\Delta r_{ON}$ , (Any Two Channels)                                      |                 | 25        | -    | 5    | -   | -          | 5    | -   | %        |    |
| Off Input Leakage Current, $I_{S(OFF)}$                                   | Note 4          | 25        | -    | 0.03 | -   | -          | 0.03 | -   | nA       |    |
|   |                 | Full      | -    | -    | 50  | -          | -    | 50  | nA       |    |
| Off Output Leakage Current, $I_{D(OFF)}$                                  | Note 4          | 25        | -    | 0.3  | -   | -          | 0.3  | -   | nA       |    |
|   |                 | HI-506    | Full | -    | -   | 300        | -    | -   | 300      | nA |
|   |                 | HI-507    | Full | -    | -   | 200        | -    | -   | 200      | nA |
|   |                 | HI-508    | Full | -    | -   | 200        | -    | -   | 200      | nA |
|   |                 | HI-509    | Full | -    | -   | 100        | -    | -   | 100      | nA |
| On Channel Leakage Current, $I_{D(ON)}$                                   | Note 4          | 25        | -    | 0.3  | -   | -          | 0.3  | -   | nA       |    |
|   |                 | HI-506    | Full | -    | -   | 300        | -    | -   | 300      | nA |
|   |                 | HI-507    | Full | -    | -   | 200        | -    | -   | 200      | nA |
|   |                 | HI-508    | Full | -    | -   | 200        | -    | -   | 200      | nA |
|   |                 | HI-509    | Full | -    | -   | 100        | -    | -   | 100      | nA |
| Differential Off Output Leakage Current, $I_{DIFF}$ (HI-507, HI-509 Only) |                 | Full      | -    | -    | 50  | -          | -    | 50  | nA       |    |
| <b>POWER SUPPLY CHARACTERISTICS</b>                                       |                 |           |      |      |     |            |      |     |          |    |
| Current, $I_+$  | HI-506/HI-507   | Note 7    | Full | -    | 1.5 | 3.0        | -    | 1.5 | 3.0      | mA |
|   | HI-508/HI-509   | Note 7    | Full | -    | 1.5 | 2.4        | -    | 1.5 | 2.4      | mA |
| Current, $I_-$  | HI-506/HI-507   | Note 7    | Full | -    | 0.4 | 1.0        | -    | 0.4 | 1.0      | mA |
|   | HI-508/HI-509   | Note 7    | Full | -    | 0.4 | 1.0        | -    | 0.4 | 1.0      | mA |
| Power Dissipation, $P_D$  | HI-506/HI-507   |           | Full | -    | -   | 60         | -    | -   | 60       | mW |
|   | HI-508/HI-509   |           | Full | -    | -   | 51         | -    | -   | 51       | mW |

**NOTES:**

3.  $V_{OUT} = \pm 10V$ ,  $I_{OUT} = \bar{\pm} 1mA$ .
4. 10nA is the practical lower limit for high speed measurement in the production test environment.
5. Digital input leakage is primarily due to the clamp diodes (see Schematic). Typical leakage is less than 1nA at 25°C.
6.  $V_{EN} = 0.8V$ ,  $R_L = 1K$ ,  $C_L = 15pF$ ,  $V_S = 7V_{RMS}$ ,  $f = 100kHz$ .
7.  $V_{EN}$ ,  $V_A = 0V$  or 2.4V.



**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified

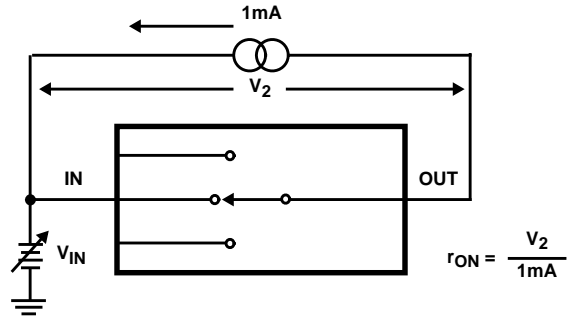


FIGURE 1A. TEST CIRCUIT

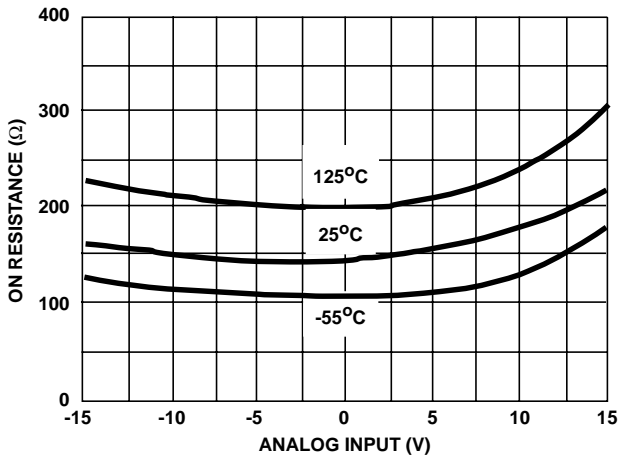


FIGURE 1B. ON RESISTANCE vs ANALOG INPUT VOLTAGE

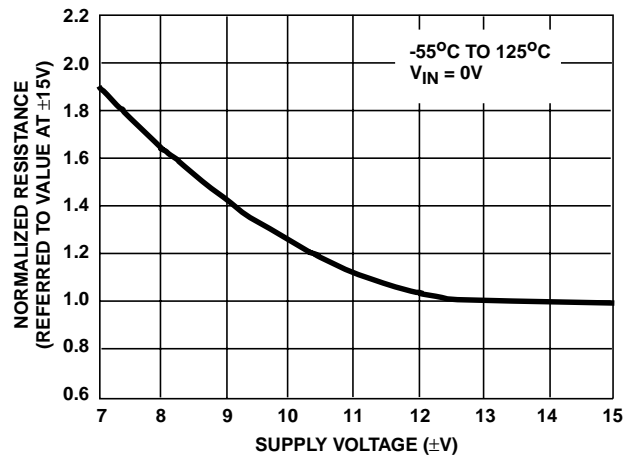


FIGURE 1C. NORMALIZED ON RESISTANCE vs SUPPLY VOLTAGE

FIGURE 1. ON RESISTANCE

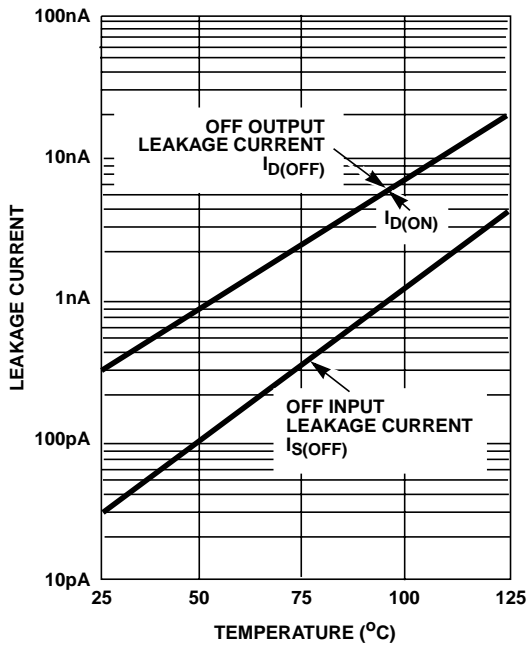


FIGURE 2A. LEAKAGE CURRENT vs TEMPERATURE

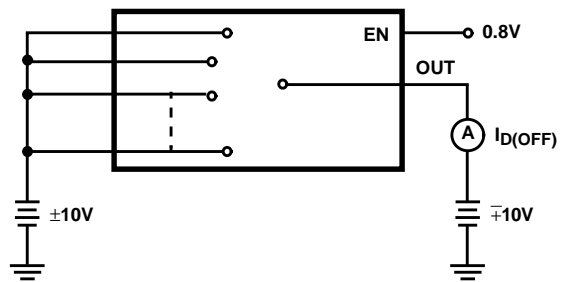


FIGURE 2B.  $I_{\text{D(OFF)}}$  TEST CIRCUIT (NOTE 8)

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

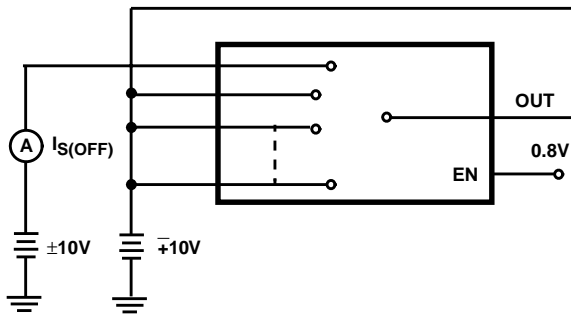


FIGURE 2C.  $I_{\text{S(OFF)}}$  TEST CIRCUIT (NOTE 8)

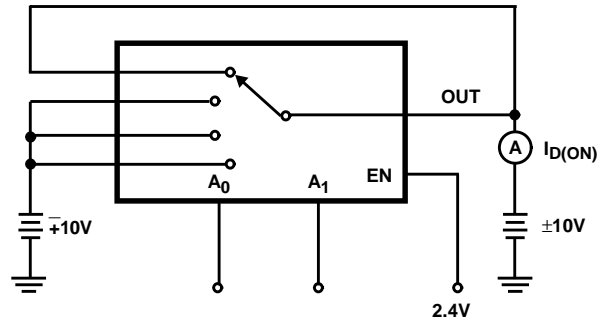


FIGURE 2D.  $I_{\text{D(ON)}}$  TEST CIRCUIT (NOTE 8)

FIGURE 2. LEAKAGE CURRENTS

NOTE:

8. Two measurements per channel:  $\pm 10\text{V}$  and  $\mp 10\text{V}$ . (Two measurements per device for  $I_{\text{D(OFF)}}$   $\pm 10\text{V}$  and  $\mp 10\text{V}$ )

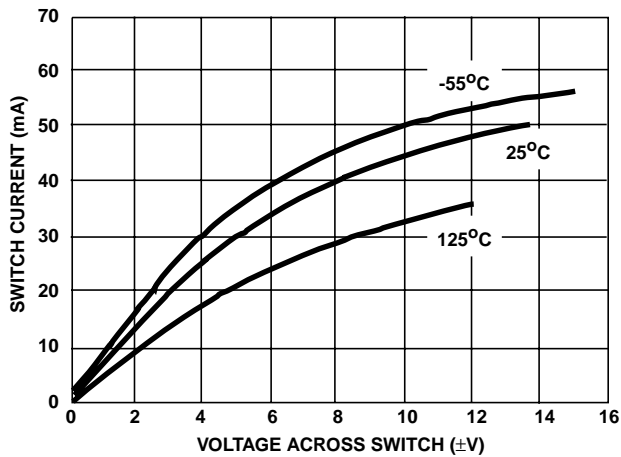


FIGURE 3A. ON CHANNEL CURRENT vs VOLTAGE

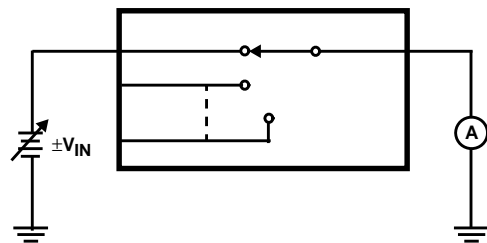


FIGURE 3B. TEST CIRCUIT

FIGURE 3. ON CHANNEL CURRENT

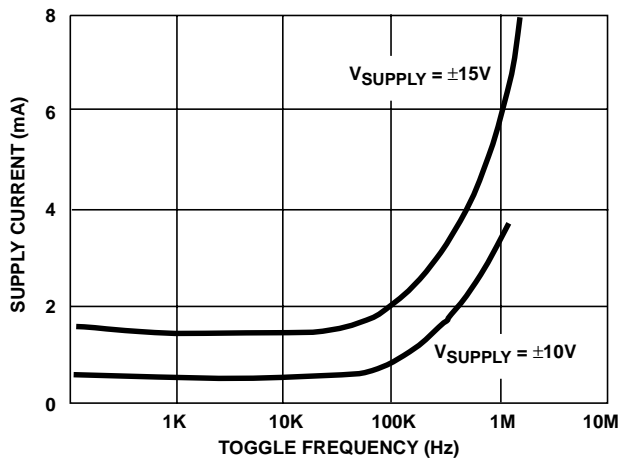


FIGURE 4A. SUPPLY CURRENT vs TOGGLE FREQUENCY

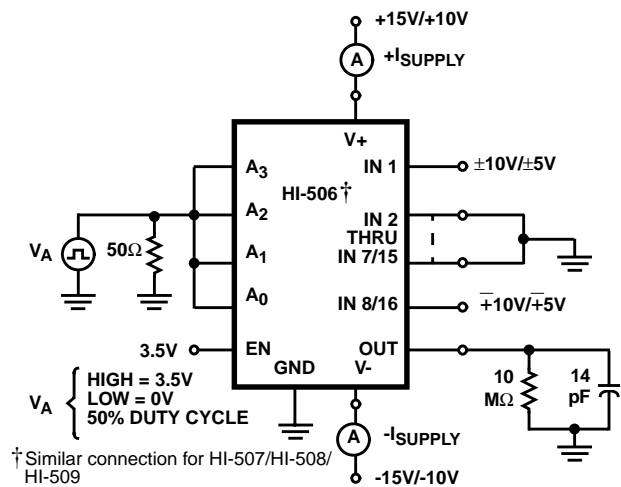


FIGURE 4B. TEST CIRCUIT

FIGURE 4. DYNAMIC SUPPLY CURRENT

† Similar connection for HI-507/HI-508/HI-509

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

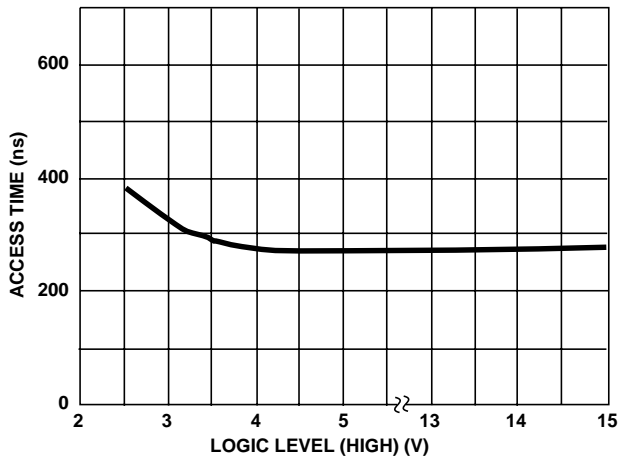
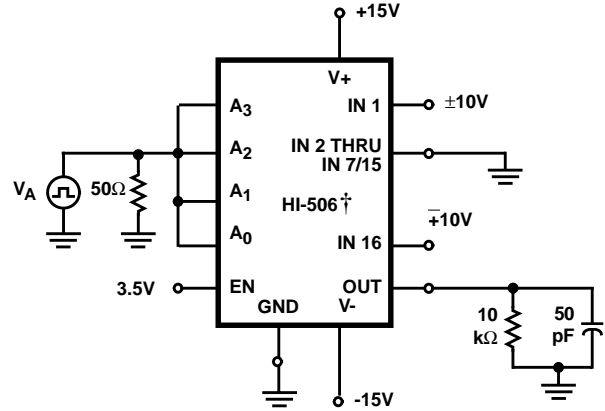


FIGURE 5A. ACCESS TIME vs LOGIC LEVEL (HIGH)



† Similar connection for HI-507/HI-508/HI-509

FIGURE 5B. TEST CIRCUIT

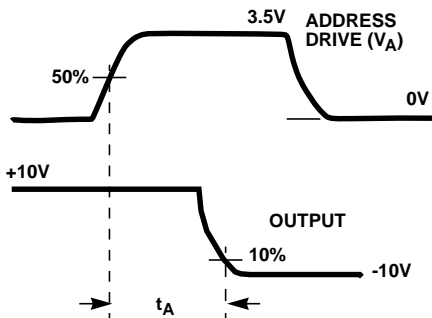


FIGURE 5C. MEASUREMENT POINTS

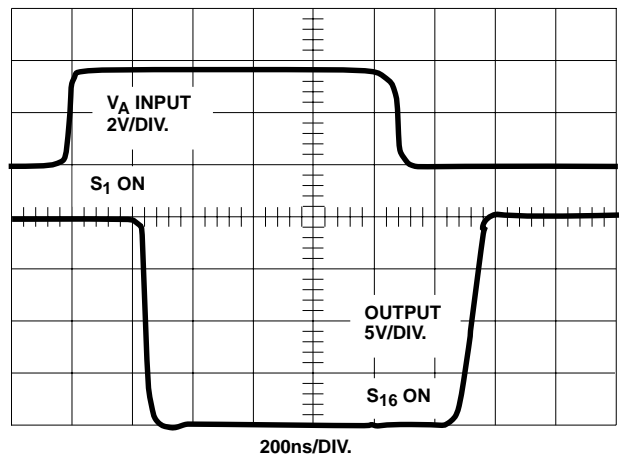
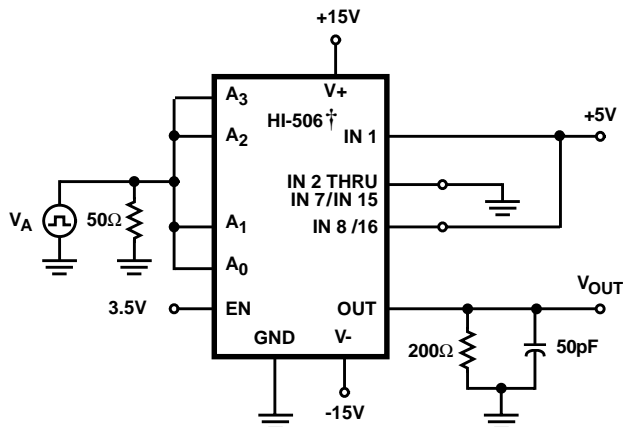


FIGURE 5D. WAVEFORMS

FIGURE 5. ACCESS TIME



† Similar connection for HI-507/HI-508/HI-509

FIGURE 6A. TEST CIRCUIT

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

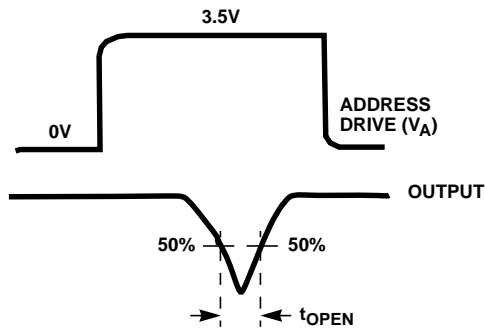


FIGURE 6B. MEASUREMENT POINTS

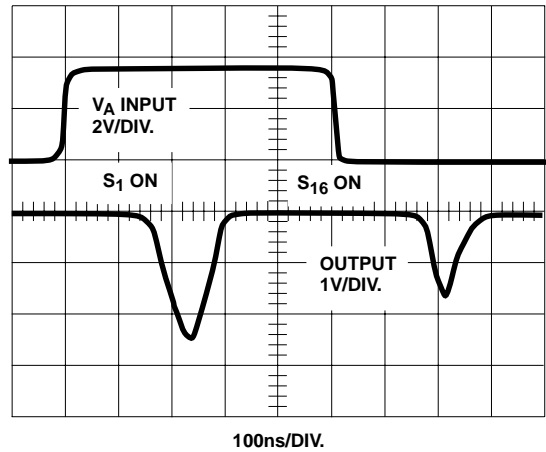
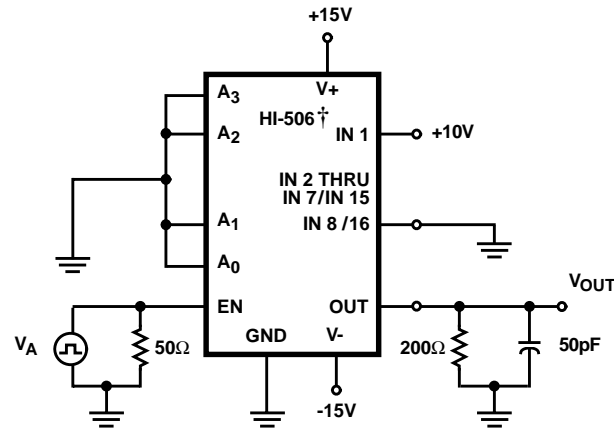


FIGURE 6C. WAVEFORMS

FIGURE 6. BREAK-BEFORE-MAKE DELAY



† Similar connection for HI-507/HI-508/HI-509

FIGURE 7A. TEST CIRCUIT

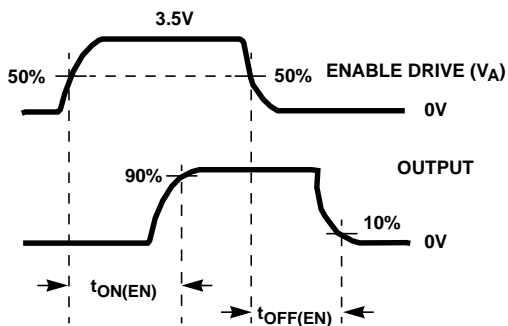


FIGURE 7B. MEASUREMENT POINTS

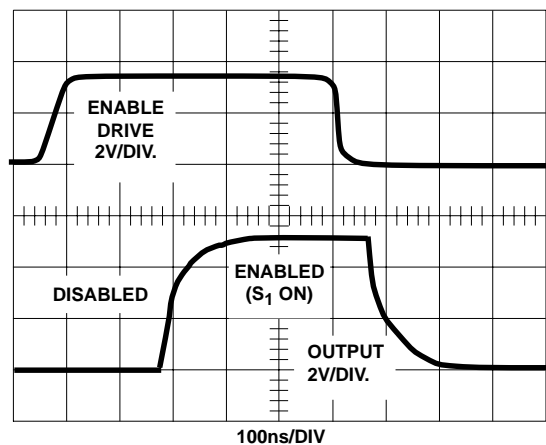


FIGURE 7C. WAVEFORMS

FIGURE 7. ENABLE DELAYS

**Typical Performance Curves**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified

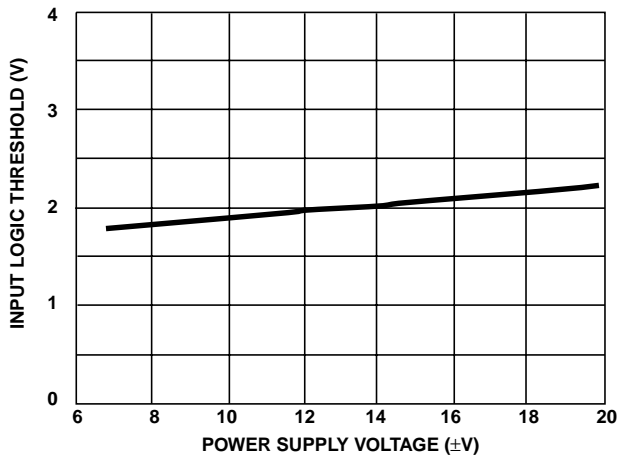


FIGURE 8. LOGIC THRESHOLD vs POWER SUPPLY VOLTAGE

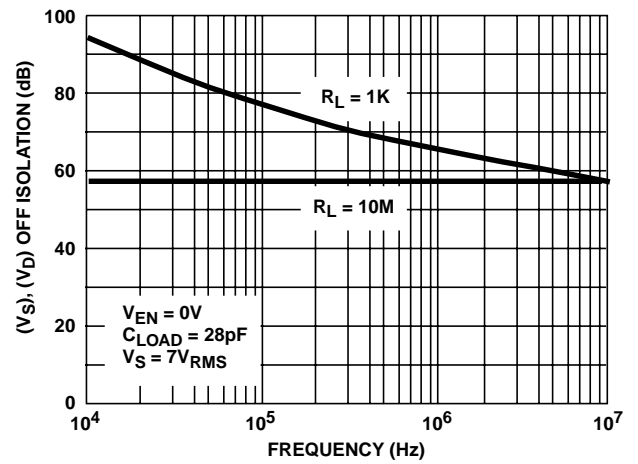


FIGURE 9. OFF ISOLATION vs FREQUENCY

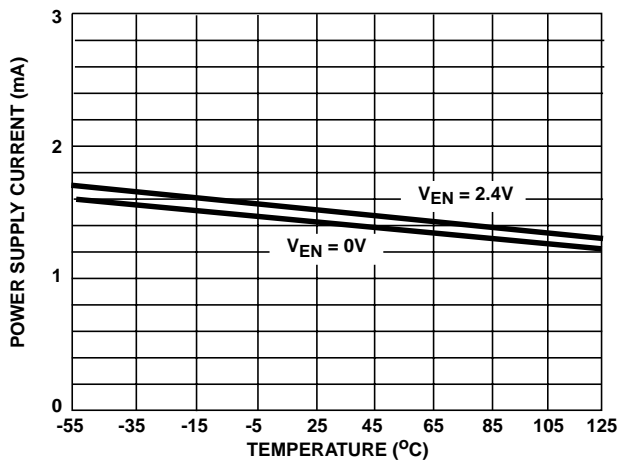


FIGURE 10A. HI-506/HI-507

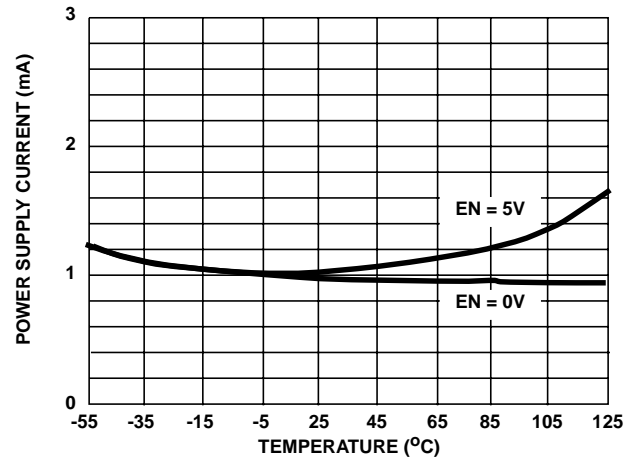


FIGURE 10B. HI-508/HI-509

FIGURE 10. POWER SUPPLY CURRENT vs TEMPERATURE

## Die Characteristics

### DIE DIMENSIONS:

129 mils x 82 mils

### METALLIZATION:

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

### SUBSTRATE POTENTIAL (NOTE):

$-V_{\text{SUPPLY}}$

### PASSIVATION:

Type: Nitride/Silox

Nitride Thickness:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

Silox Thickness:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

### WORST CASE CURRENT DENSITY:

$1.4 \times 10^5 \text{ A/cm}^2$

### TRANSISTOR COUNT:

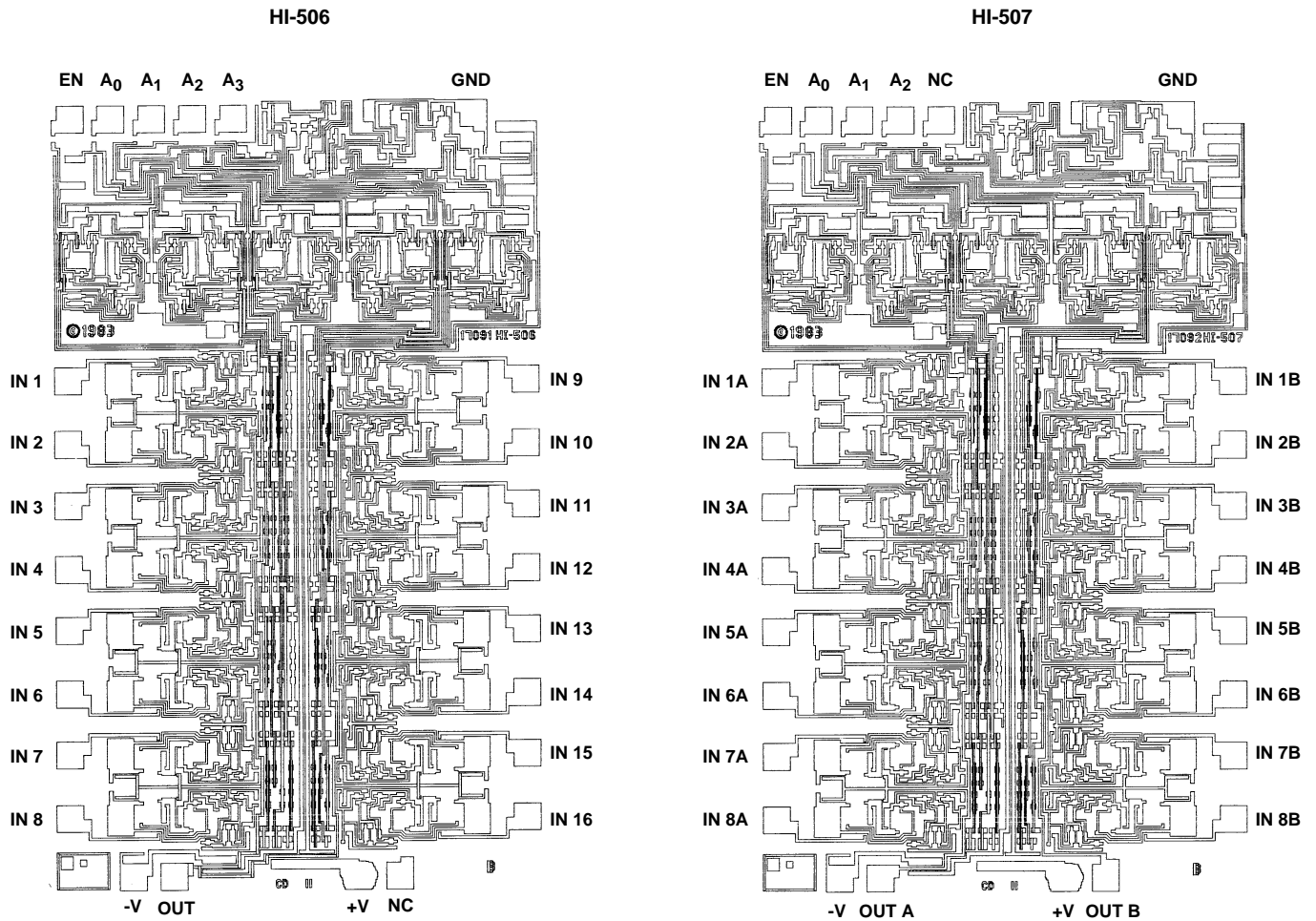
421

### PROCESS:

CMOS-DI

NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

## Metallization Mask Layout



**Die Characteristics**

**DIE DIMENSIONS:**

81.9 mils x 90.2 mils

**METALLIZATION:**

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**SUBSTRATE POTENTIAL (NOTE):**

$-V_{\text{SUPPLY}}$

**PASSIVATION:**

Type: Nitride/Silox

Nitride Thickness:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

Silox Thickness:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**WORST CASE CURRENT DENSITY:**

$1.4 \times 10^5 \text{ A/cm}^2$

**TRANSISTOR COUNT:**

234

**PROCESS:**

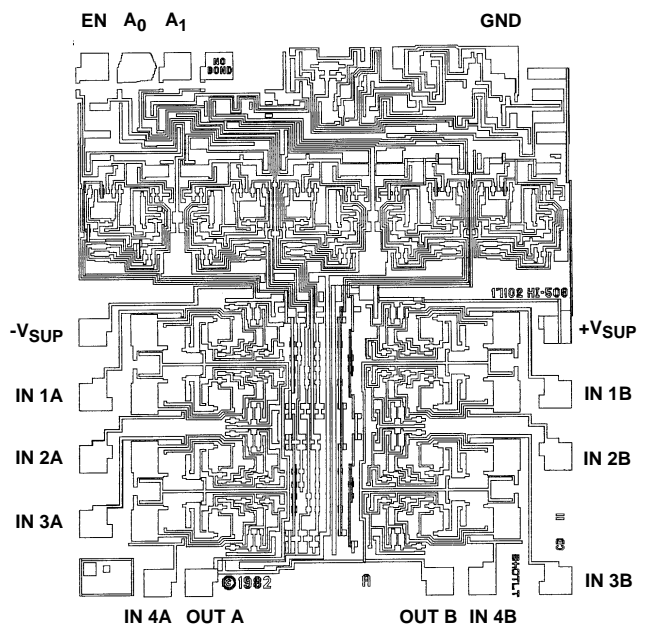
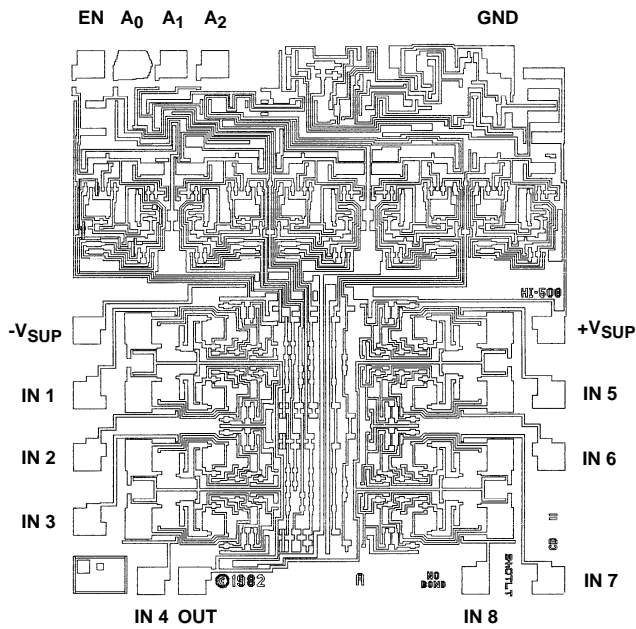
CMOS-DI

NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

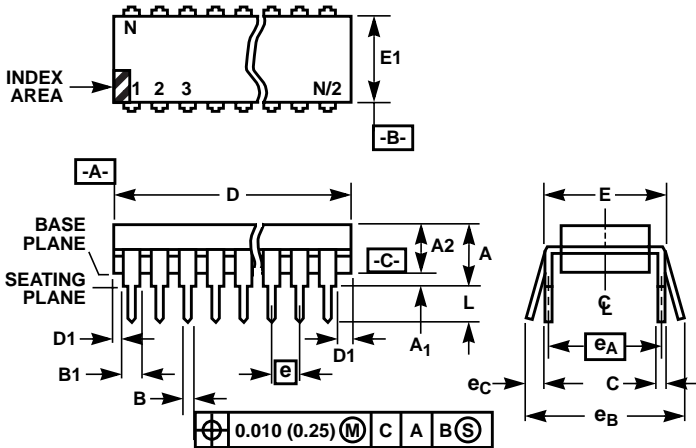
**Metallization Mask Layout**

HI-508

HI-509



Dual-In-Line Plastic Packages (PDIP)



NOTES:

- Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
- D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- E and  $e_A$  are measured with the leads constrained to be perpendicular to datum  $-C-$ .
- $e_B$  and  $e_C$  are measured at the lead tips with the leads unconstrained.  $e_C$  must be zero or greater.
- B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- N is the maximum number of terminal positions.
- Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

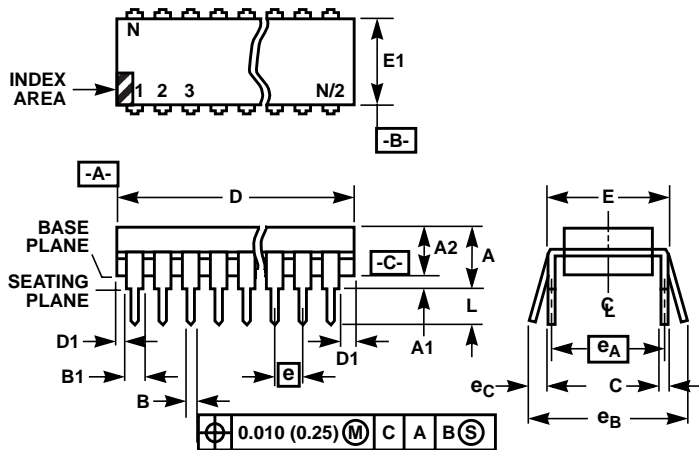
E8.3 (JEDEC MS-001-BA ISSUE D)  
8 LEAD DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.210 | -           | 5.33  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.115     | 0.195 | 2.93        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.045     | 0.070 | 1.15        | 1.77  | 8, 10 |
| C      | 0.008     | 0.014 | 0.204       | 0.355 | -     |
| D      | 0.355     | 0.400 | 9.01        | 10.16 | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.300     | 0.325 | 7.62        | 8.25  | 6     |
| E1     | 0.240     | 0.280 | 6.10        | 7.11  | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| $e_A$  | 0.300 BSC |       | 7.62 BSC    |       | 6     |
| $e_B$  | -         | 0.430 | -           | 10.92 | 7     |
| L      | 0.115     | 0.150 | 2.93        | 3.81  | 4     |
| N      | 8         |       | 8           |       | 9     |

Rev. 0 12/93



Dual-In-Line Plastic Packages (PDIP)



NOTES:

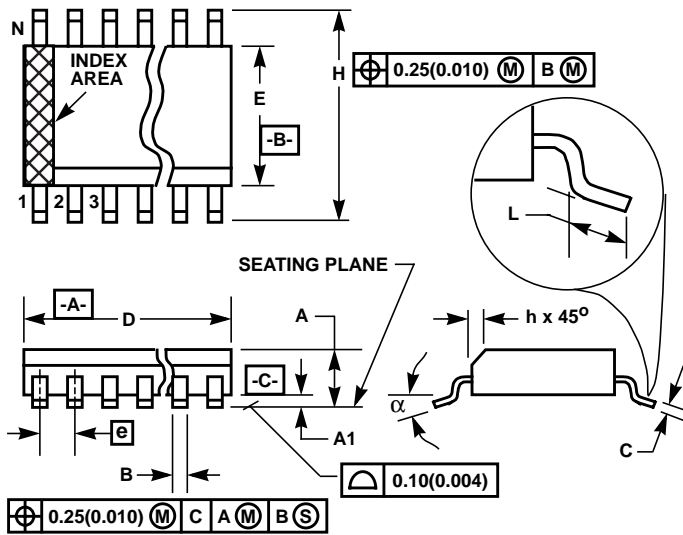
- Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
- D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- E and  $e_A$  are measured with the leads constrained to be perpendicular to datum  $-C-$ .
- $e_B$  and  $e_C$  are measured at the lead tips with the leads unconstrained.  $e_C$  must be zero or greater.
- B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- N is the maximum number of terminal positions.
- Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E28.6 (JEDEC MS-001-BF ISSUE D)  
28 LEAD NARROW BODY DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.250 | -           | 6.35  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.125     | 0.195 | 3.18        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.030     | 0.070 | 0.77        | 1.77  | 8     |
| C      | 0.008     | 0.015 | 0.204       | 0.381 | -     |
| D      | 1.380     | 1.565 | 35.1        | 39.7  | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.600     | 0.625 | 15.24       | 15.87 | 6     |
| E1     | 0.485     | 0.580 | 12.32       | 14.73 | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| $e_A$  | 0.600 BSC |       | 15.24 BSC   |       | 6     |
| $e_B$  | -         | 0.700 | -           | 17.78 | 7     |
| L      | 0.115     | 0.200 | 2.93        | 5.08  | 4     |
| N      | 28        |       | 28          |       | 9     |

Rev. 0 12/93

Small Outline Plastic Packages (SOIC)



**M16.15** (JEDEC MS-012-AC ISSUE C)  
16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

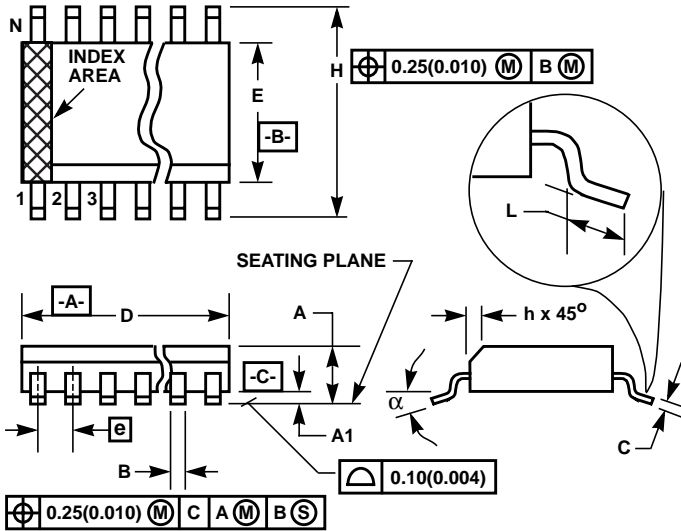
| SYMBOL   | INCHES    |        | MILLIMETERS |       | NOTES |
|----------|-----------|--------|-------------|-------|-------|
|          | MIN       | MAX    | MIN         | MAX   |       |
| A        | 0.0532    | 0.0688 | 1.35        | 1.75  | -     |
| A1       | 0.0040    | 0.0098 | 0.10        | 0.25  | -     |
| B        | 0.013     | 0.020  | 0.33        | 0.51  | 9     |
| C        | 0.0075    | 0.0098 | 0.19        | 0.25  | -     |
| D        | 0.3859    | 0.3937 | 9.80        | 10.00 | 3     |
| E        | 0.1497    | 0.1574 | 3.80        | 4.00  | 4     |
| e        | 0.050 BSC |        | 1.27 BSC    |       | -     |
| H        | 0.2284    | 0.2440 | 5.80        | 6.20  | -     |
| h        | 0.0099    | 0.0196 | 0.25        | 0.50  | 5     |
| L        | 0.016     | 0.050  | 0.40        | 1.27  | 6     |
| N        | 16        |        | 16          |       | 7     |
| $\alpha$ | 0°        | 8°     | 0°          | 8°    | -     |

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

Rev. 0 12/93

Small Outline Plastic Packages (SOIC)



**M28.3 (JEDEC MS-013-AE ISSUE C)**  
**28 LEAD WIDE BODY SMALL OUTLINE PLASTIC PACKAGE**

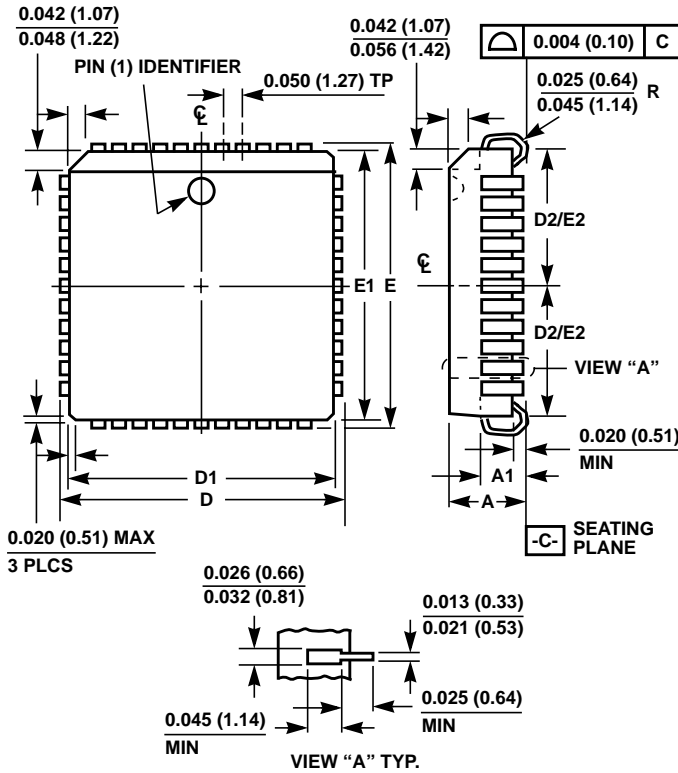
| SYMBOL | INCHES   |        | MILLIMETERS |       | NOTES |
|--------|----------|--------|-------------|-------|-------|
|        | MIN      | MAX    | MIN         | MAX   |       |
| A      | 0.0926   | 0.1043 | 2.35        | 2.65  | -     |
| A1     | 0.0040   | 0.0118 | 0.10        | 0.30  | -     |
| B      | 0.013    | 0.0200 | 0.33        | 0.51  | 9     |
| C      | 0.0091   | 0.0125 | 0.23        | 0.32  | -     |
| D      | 0.6969   | 0.7125 | 17.70       | 18.10 | 3     |
| E      | 0.2914   | 0.2992 | 7.40        | 7.60  | 4     |
| e      | 0.05 BSC |        | 1.27 BSC    |       | -     |
| H      | 0.394    | 0.419  | 10.00       | 10.65 | -     |
| h      | 0.01     | 0.029  | 0.25        | 0.75  | 5     |
| L      | 0.016    | 0.050  | 0.40        | 1.27  | 6     |
| N      | 28       |        | 28          |       | 7     |
| alpha  | 0°       | 8°     | 0°          | 8°    | -     |

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch)
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

Rev. 0 12/93

Plastic Leaded Chip Carrier Packages (PLCC)



N20.35 (JEDEC MS-018AA ISSUE A)  
20 LEAD PLASTIC LEADED CHIP CARRIER PACKAGE

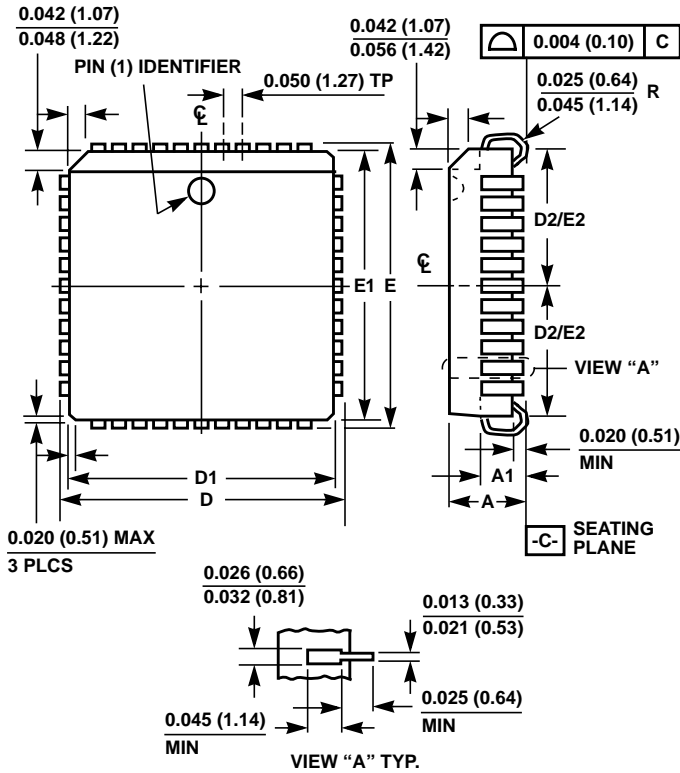
| SYMBOL | INCHES |       | MILLIMETERS |       | NOTES |
|--------|--------|-------|-------------|-------|-------|
|        | MIN    | MAX   | MIN         | MAX   |       |
| A      | 0.165  | 0.180 | 4.20        | 4.57  | -     |
| A1     | 0.090  | 0.120 | 2.29        | 3.04  | -     |
| D      | 0.385  | 0.395 | 9.78        | 10.03 | -     |
| D1     | 0.350  | 0.356 | 8.89        | 9.04  | 3     |
| D2     | 0.141  | 0.169 | 3.59        | 4.29  | 4, 5  |
| E      | 0.385  | 0.395 | 9.78        | 10.03 | -     |
| E1     | 0.350  | 0.356 | 8.89        | 9.04  | 3     |
| E2     | 0.141  | 0.169 | 3.59        | 4.29  | 4, 5  |
| N      | 20     |       | 20          |       | 6     |

Rev. 2 11/97

NOTES:

1. Controlling dimension: INCH. Converted millimeter dimensions are not necessarily exact.
2. Dimensions and tolerancing per ANSI Y14.5M-1982.
3. Dimensions D1 and E1 do not include mold protrusions. Allowable mold protrusion is 0.010 inch (0.25mm) per side. Dimensions D1 and E1 include mold mismatch and are measured at the extreme material condition at the body parting line.
4. To be measured at seating plane [-C-] contact point.
5. Centerline to be determined where center leads exit plastic body.
6. "N" is the number of terminal positions.

Plastic Leaded Chip Carrier Packages (PLCC)



N28.45 (JEDEC MS-018AB ISSUE A)  
28 LEAD PLASTIC LEADED CHIP CARRIER PACKAGE

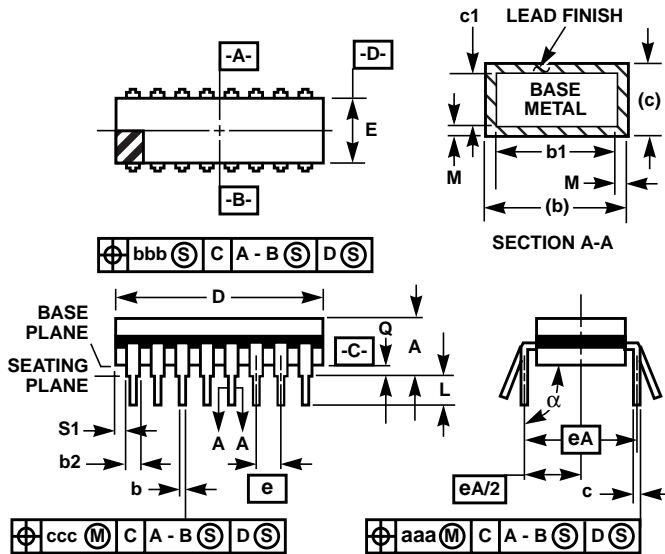
| SYMBOL | INCHES |       | MILLIMETERS |       | NOTES |
|--------|--------|-------|-------------|-------|-------|
|        | MIN    | MAX   | MIN         | MAX   |       |
| A      | 0.165  | 0.180 | 4.20        | 4.57  | -     |
| A1     | 0.090  | 0.120 | 2.29        | 3.04  | -     |
| D      | 0.485  | 0.495 | 12.32       | 12.57 | -     |
| D1     | 0.450  | 0.456 | 11.43       | 11.58 | 3     |
| D2     | 0.191  | 0.219 | 4.86        | 5.56  | 4, 5  |
| E      | 0.485  | 0.495 | 12.32       | 12.57 | -     |
| E1     | 0.450  | 0.456 | 11.43       | 11.58 | 3     |
| E2     | 0.191  | 0.219 | 4.86        | 5.56  | 4, 5  |
| N      | 28     |       | 28          |       | 6     |

Rev. 2 11/97

NOTES:

- Controlling dimension: INCH. Converted millimeter dimensions are not necessarily exact.
- Dimensions and tolerancing per ANSI Y14.5M-1982.
- Dimensions D1 and E1 do not include mold protrusions. Allowable mold protrusion is 0.010 inch (0.25mm) per side. Dimensions D1 and E1 include mold mismatch and are measured at the extreme material condition at the body parting line.
- To be measured at seating plane -C- contact point.
- Centerline to be determined where center leads exit plastic body.
- "N" is the number of terminal positions.

**Ceramic Dual-In-Line Frit Seal Packages (CERDIP)**



**F16.3 MIL-STD-1835 GDIP1-T16 (D-2, CONFIGURATION A)  
16 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE**

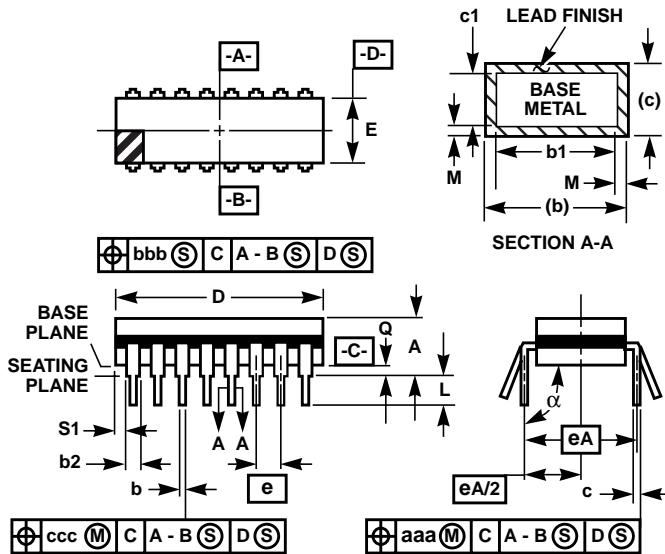
| SYMBOL | INCHES    |        | MILLIMETERS |       | NOTES |
|--------|-----------|--------|-------------|-------|-------|
|        | MIN       | MAX    | MIN         | MAX   |       |
| A      | -         | 0.200  | -           | 5.08  | -     |
| b      | 0.014     | 0.026  | 0.36        | 0.66  | 2     |
| b1     | 0.014     | 0.023  | 0.36        | 0.58  | 3     |
| b2     | 0.045     | 0.065  | 1.14        | 1.65  | -     |
| b3     | 0.023     | 0.045  | 0.58        | 1.14  | 4     |
| c      | 0.008     | 0.018  | 0.20        | 0.46  | 2     |
| c1     | 0.008     | 0.015  | 0.20        | 0.38  | 3     |
| D      | -         | 0.840  | -           | 21.34 | 5     |
| E      | 0.220     | 0.310  | 5.59        | 7.87  | 5     |
| e      | 0.100 BSC |        | 2.54 BSC    |       | -     |
| eA     | 0.300 BSC |        | 7.62 BSC    |       | -     |
| eA/2   | 0.150 BSC |        | 3.81 BSC    |       | -     |
| L      | 0.125     | 0.200  | 3.18        | 5.08  | -     |
| Q      | 0.015     | 0.060  | 0.38        | 1.52  | 6     |
| S1     | 0.005     | -      | 0.13        | -     | 7     |
| alpha  | 90°       | 105°   | 90°         | 105°  | -     |
| aaa    | -         | 0.015  | -           | 0.38  | -     |
| bbb    | -         | 0.030  | -           | 0.76  | -     |
| ccc    | -         | 0.010  | -           | 0.25  | -     |
| M      | -         | 0.0015 | -           | 0.038 | 2, 3  |
| N      | 16        |        | 16          |       | 8     |

**NOTES:**

1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark.
2. The maximum limits of lead dimensions b and c or M shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
3. Dimensions b1 and c1 apply to lead base metal only. Dimension M applies to lead plating and finish thickness.
4. Corner leads (1, N, N/2, and N/2+1) may be configured with a partial lead paddle. For this configuration dimension b3 replaces dimension b2.
5. This dimension allows for off-center lid, meniscus, and glass overrun.
6. Dimension Q shall be measured from the seating plane to the base plane.
7. Measure dimension S1 at all four corners.
8. N is the maximum number of terminal positions.
9. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
10. Controlling dimension: INCH.

Rev. 0 4/94

**Ceramic Dual-In-Line Frit Seal Packages (CERDIP)**



**F28.6 MIL-STD-1835 GDIP1-T28 (D-10, CONFIGURATION A)  
28 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE**

| SYMBOL | INCHES    |        | MILLIMETERS |       | NOTES |
|--------|-----------|--------|-------------|-------|-------|
|        | MIN       | MAX    | MIN         | MAX   |       |
| A      | -         | 0.232  | -           | 5.92  | -     |
| b      | 0.014     | 0.026  | 0.36        | 0.66  | 2     |
| b1     | 0.014     | 0.023  | 0.36        | 0.58  | 3     |
| b2     | 0.045     | 0.065  | 1.14        | 1.65  | -     |
| b3     | 0.023     | 0.045  | 0.58        | 1.14  | 4     |
| c      | 0.008     | 0.018  | 0.20        | 0.46  | 2     |
| c1     | 0.008     | 0.015  | 0.20        | 0.38  | 3     |
| D      | -         | 1.490  | -           | 37.85 | 5     |
| E      | 0.500     | 0.610  | 12.70       | 15.49 | 5     |
| e      | 0.100 BSC |        | 2.54 BSC    |       | -     |
| eA     | 0.600 BSC |        | 15.24 BSC   |       | -     |
| eA/2   | 0.300 BSC |        | 7.62 BSC    |       | -     |
| L      | 0.125     | 0.200  | 3.18        | 5.08  | -     |
| Q      | 0.015     | 0.060  | 0.38        | 1.52  | 6     |
| S1     | 0.005     | -      | 0.13        | -     | 7     |
| α      | 90°       | 105°   | 90°         | 105°  | -     |
| aaa    | -         | 0.015  | -           | 0.38  | -     |
| bbb    | -         | 0.030  | -           | 0.76  | -     |
| ccc    | -         | 0.010  | -           | 0.25  | -     |
| M      | -         | 0.0015 | -           | 0.038 | 2, 3  |
| N      | 28        |        | 28          |       | 8     |

**NOTES:**

1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark.
2. The maximum limits of lead dimensions b and c or M shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
3. Dimensions b1 and c1 apply to lead base metal only. Dimension M applies to lead plating and finish thickness.
4. Corner leads (1, N, N/2, and N/2+1) may be configured with a partial lead paddle. For this configuration dimension b3 replaces dimension b2.
5. This dimension allows for off-center lid, meniscus, and glass overrun.
6. Dimension Q shall be measured from the seating plane to the base plane.
7. Measure dimension S1 at all four corners.
8. N is the maximum number of terminal positions.
9. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
10. Controlling dimension: INCH.

Rev. 0 4/94

All Intersil semiconductor products are manufactured, assembled and tested under **ISO9000** quality systems certification.

*Intersil semiconductor products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.*

For information regarding Intersil Corporation and its products, see web site <http://www.intersil.com>

**Sales Office Headquarters**

**NORTH AMERICA**

Intersil Corporation  
P. O. Box 883, Mail Stop 53-204  
Melbourne, FL 32902  
TEL: (407) 724-7000  
FAX: (407) 724-7240

**EUROPE**

Intersil SA  
Mercure Center  
100, Rue de la Fusee  
1130 Brussels, Belgium  
TEL: (32) 2.724.2111  
FAX: (32) 2.724.22.05

**ASIA**

Intersil (Taiwan) Ltd.  
7F-6, No. 101 Fu Hsing North Road  
Taipei, Taiwan  
Republic of China  
TEL: (886) 2 2716 9310  
FAX: (886) 2 2715 3029